

奈米科技導論

Nano-photonics of II-VI semiconductors

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大綱:

Part I: 半導體奈米結構成長-----

分子束磊晶(molecular beam epitaxy)

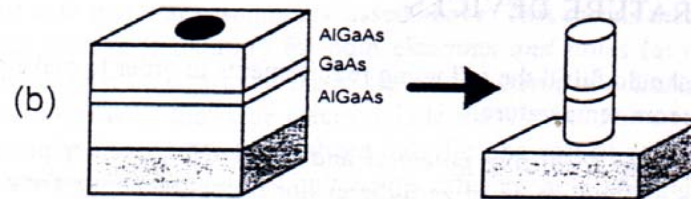
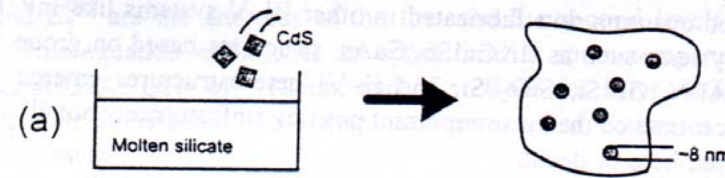
半導體奈米結構形貌研究---AFM

Part II: 半導體奈米結構光電特性---Photoluminescence

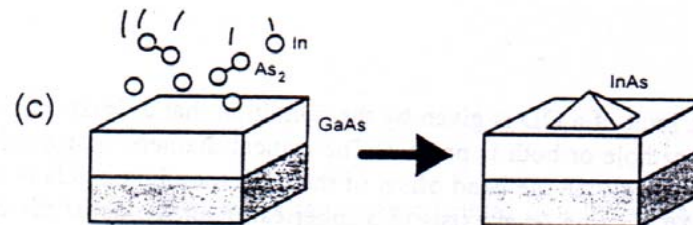
Part III: 半導體奈米光電元件

Part IV: 半磁性半導體奈米結構之自旋磁光特性

有幾種製作半導體奈米結構或量子點的方法?



Top down

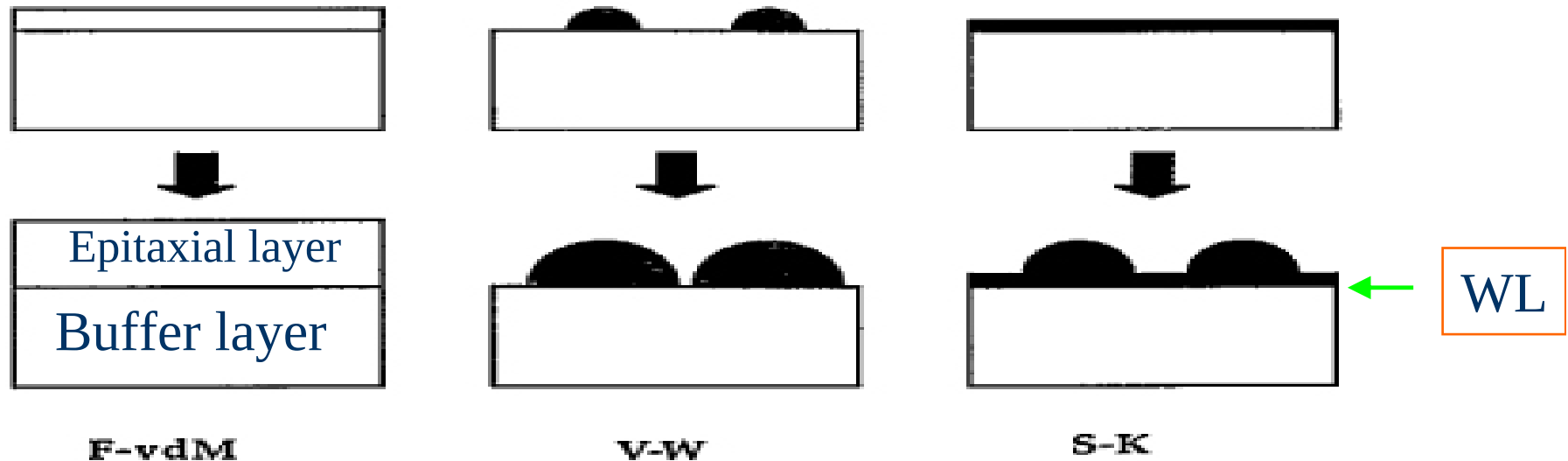


Bottom up

(a) Microcrystallites in glass

(b) Quantum dots fabricated by lithographic techniques

(c) Self-organized quantum dots (d) Chemical synthesis



Frank-van der Merwe
二維長晶模式

Volmer-Weber (VW)
三維長晶模式

Stranski-Krastanow (SK)
從二維到三維長晶模式
(wetting layer, WL)

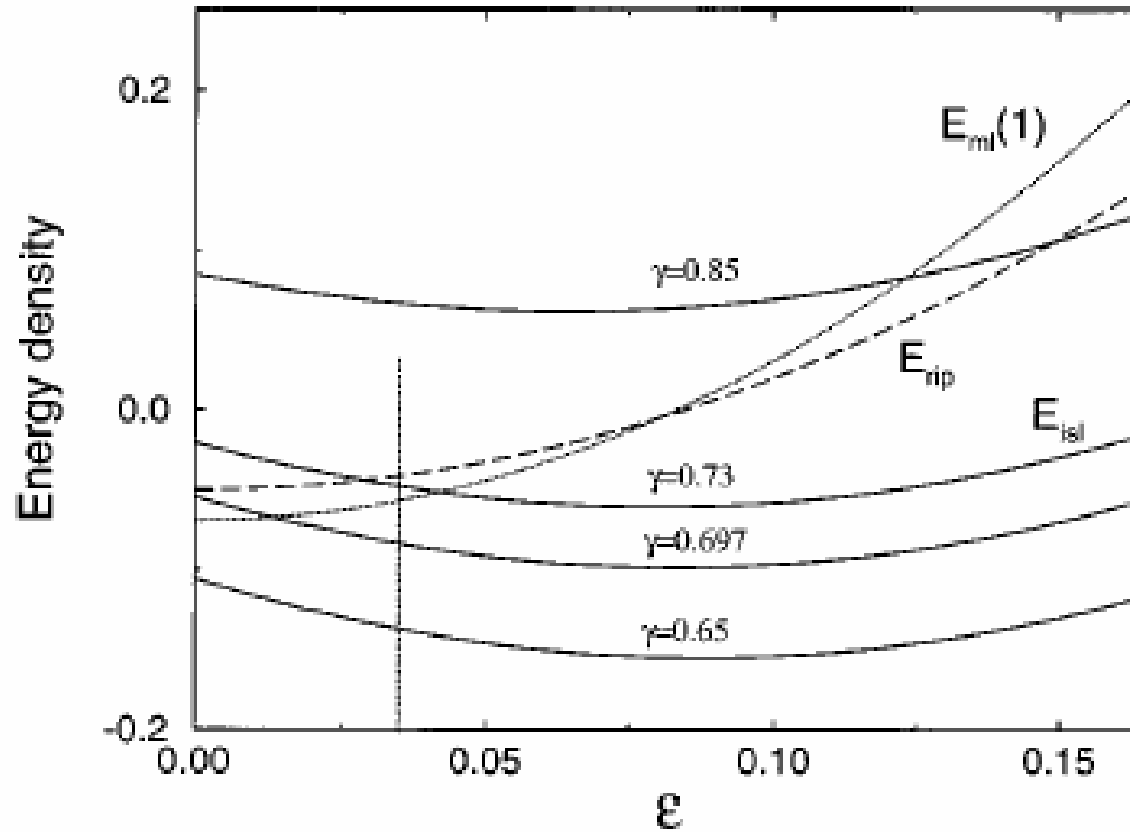
Self assembled (organized) quantum dots, SAQD.

$$u(H, n_1, n_2, \varepsilon) = E_{\text{ml}}(n_1) + n_2 E_{\text{isl}} + (H - n_1 - n_2) E_{\text{rip}}$$

$$E_{\text{ml}}(n_1) = \int dn \{ G + \Delta [\Theta(1-n) + \Theta(n-1) e^{-(n-1)/a}] \} \quad G = C \varepsilon^2 - \Phi_{\text{AA}}$$

$$E_{\text{isl}} = gC \varepsilon^2 - \Phi_{\text{AA}} + E_0 [-(2/x^2) \ln e^{1/2} x + \alpha/x + \beta(n_2)/x^{3/2}]$$

$$E_{\text{rip}} = E_{\text{isl}} (x \rightarrow \infty) = gC \varepsilon^2 - \Phi_{\text{AA}}$$

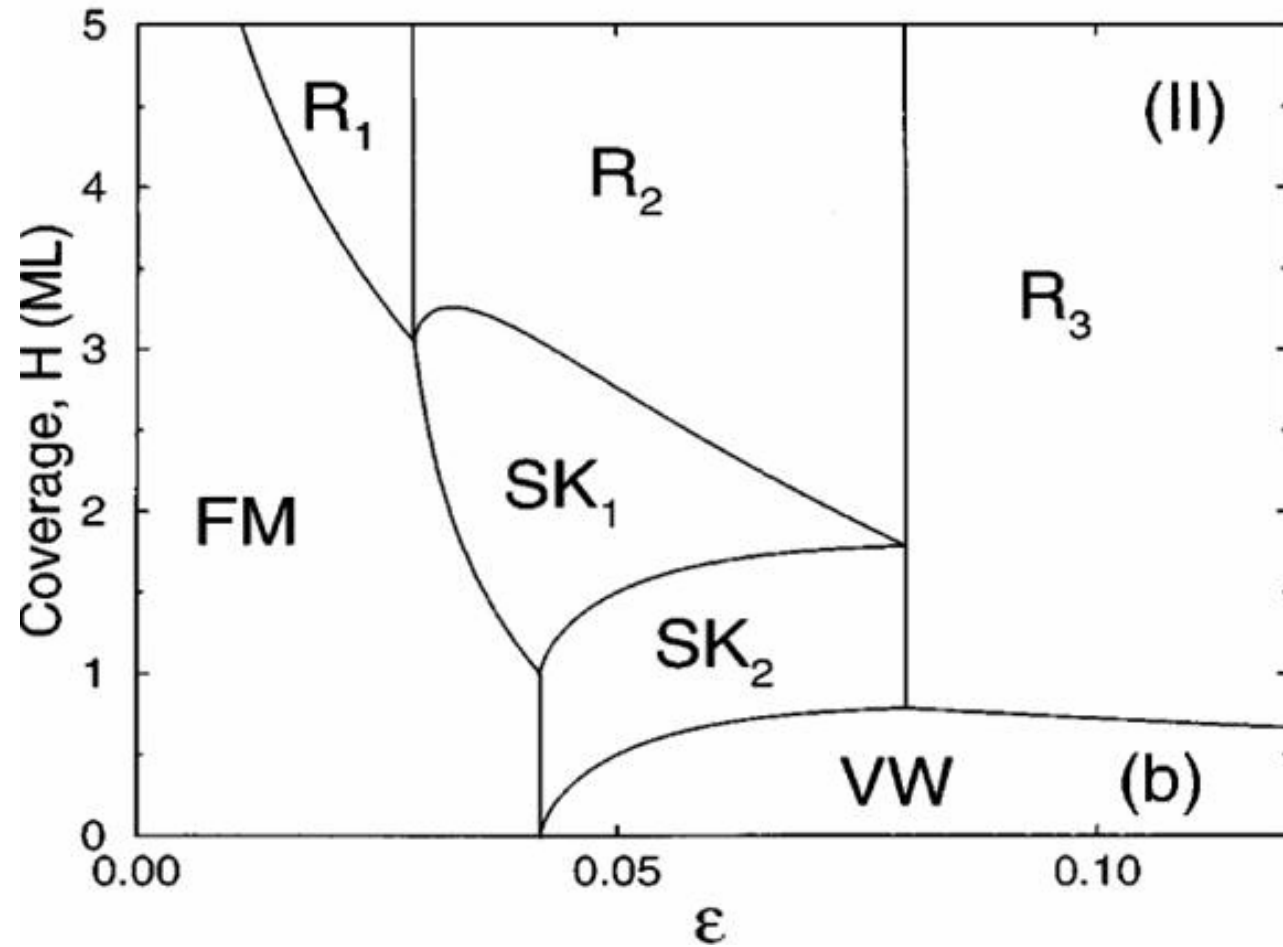


$$u(H, n_1, n_2, \varepsilon) = E_{ml}(n_1) + n_2 E_{isl} + (H - n_1 - n_2) E_{rip}$$

$$E_{ml}(n_1) = \int dn \{ G + \Delta [\Theta(1-n) + \Theta(n-1) e^{-(n-1)/a}] \} \quad G = C \varepsilon^2 - \Phi_{AA}$$

$$E_{isl} = gC \varepsilon^2 - \Phi_{AA} + E_0 [-(2/x^2) \ln e^{1/2} x + \alpha/x + \beta(n_2)/x^{3/2}]$$

$$E_{rip} = E_{isl}(x \rightarrow \infty) = gC \varepsilon^2 - \Phi_{AA}$$

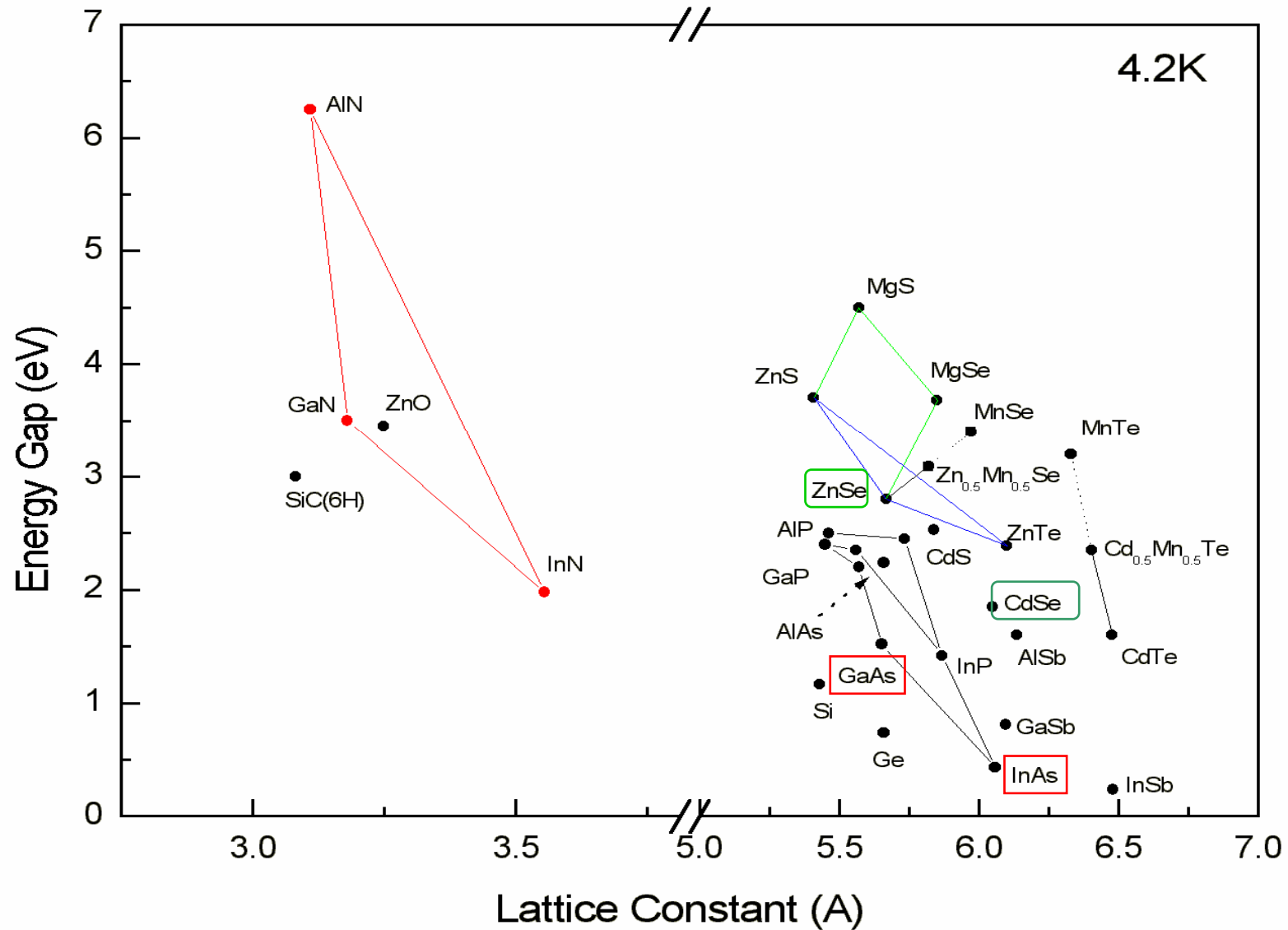


$$u(H, n_1, n_2, \varepsilon) = E_{\text{ml}}(n_1) + n_2 E_{\text{isl}} + (H - n_1 - n_2)E_{\text{rip}}$$

- ◆ I. Daruka and A.L. Barabasi, APL 72, 2102 (1998)

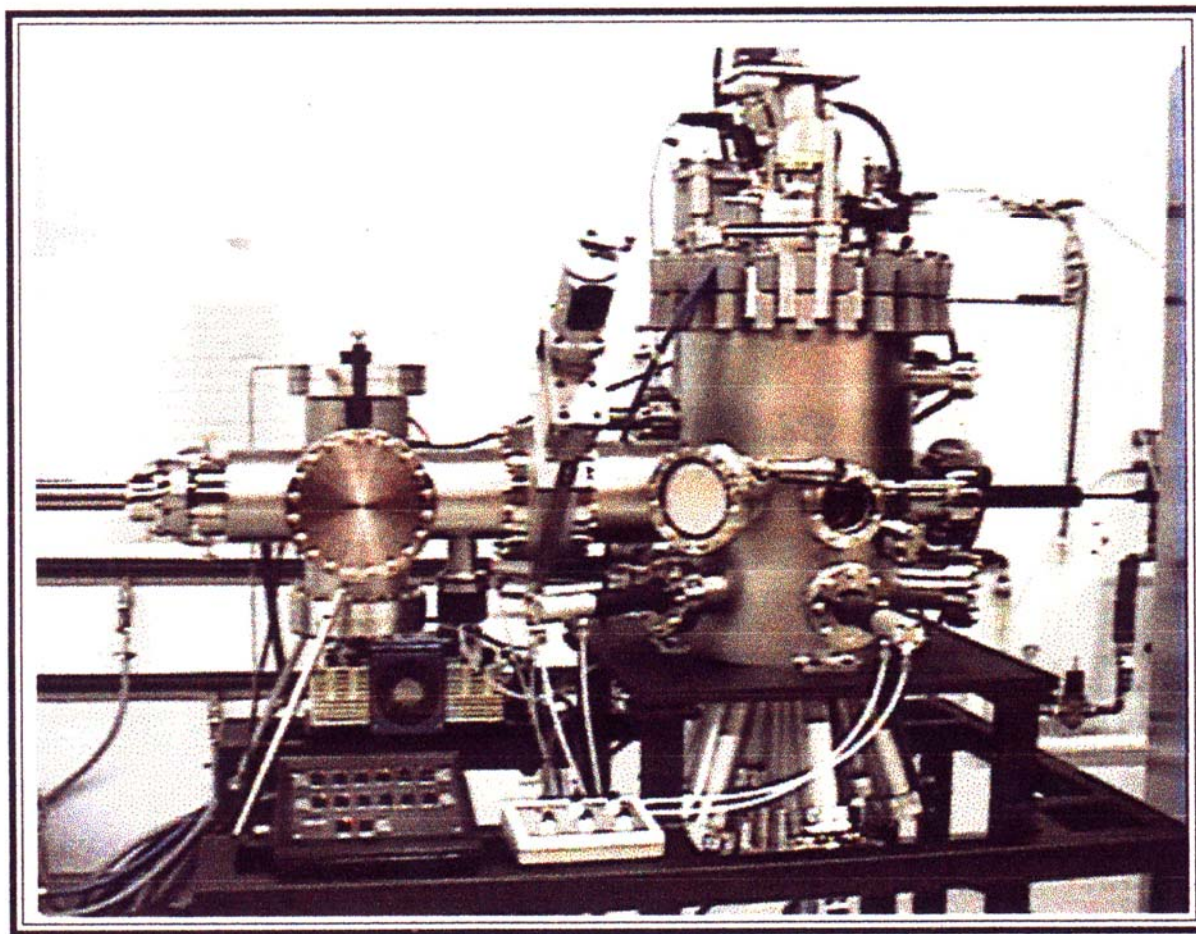
Energy Gap vs Lattice Constant

(材料) 菜色豐富千變萬化



如何製作半導體奈米結構？

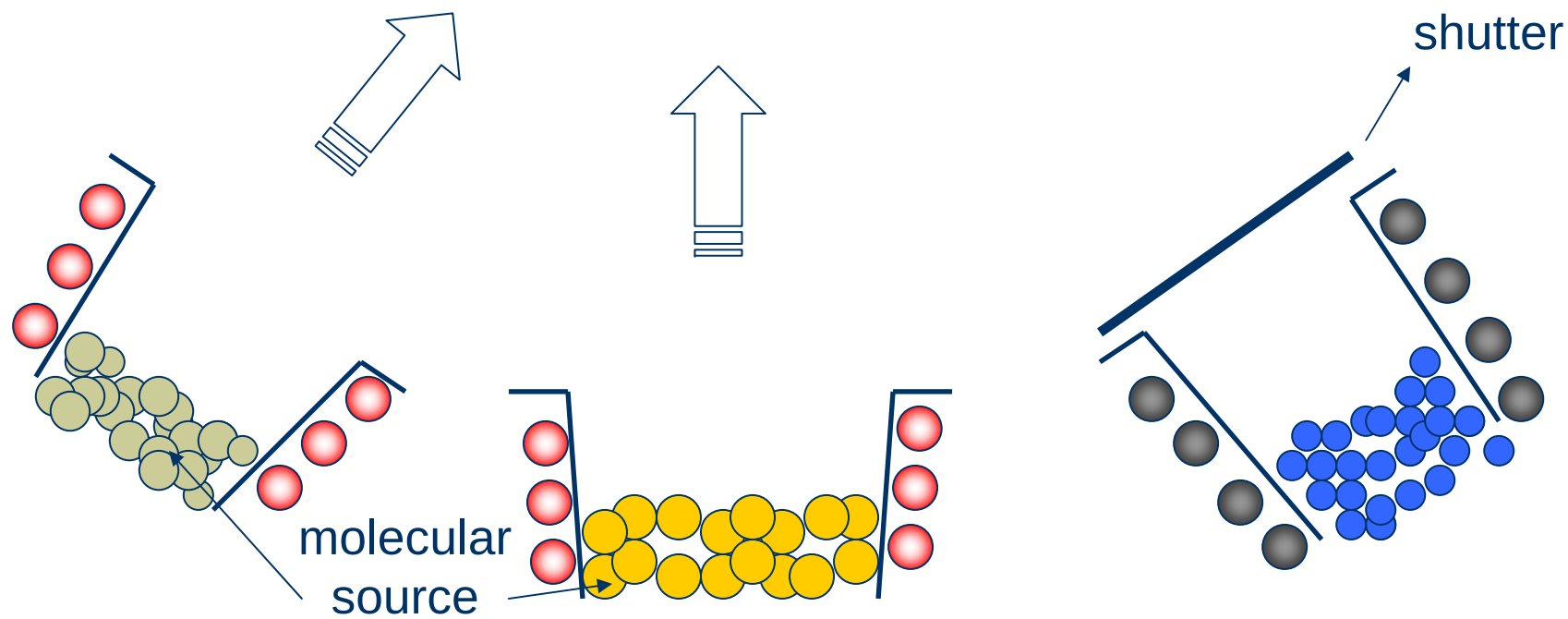
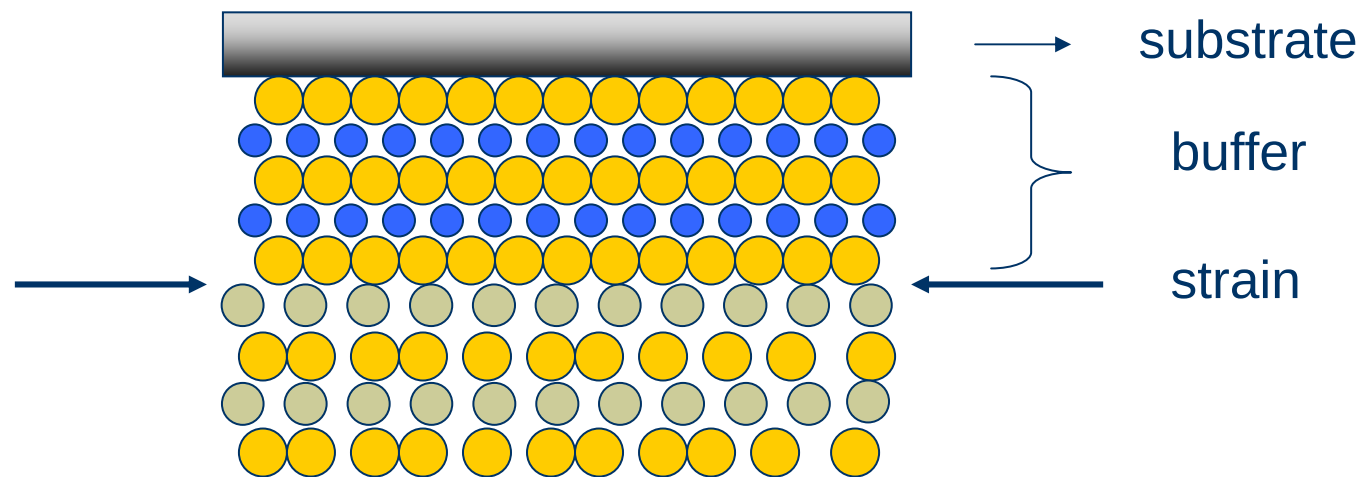
EPI
Model 620
Molecular Beam Epitaxy System

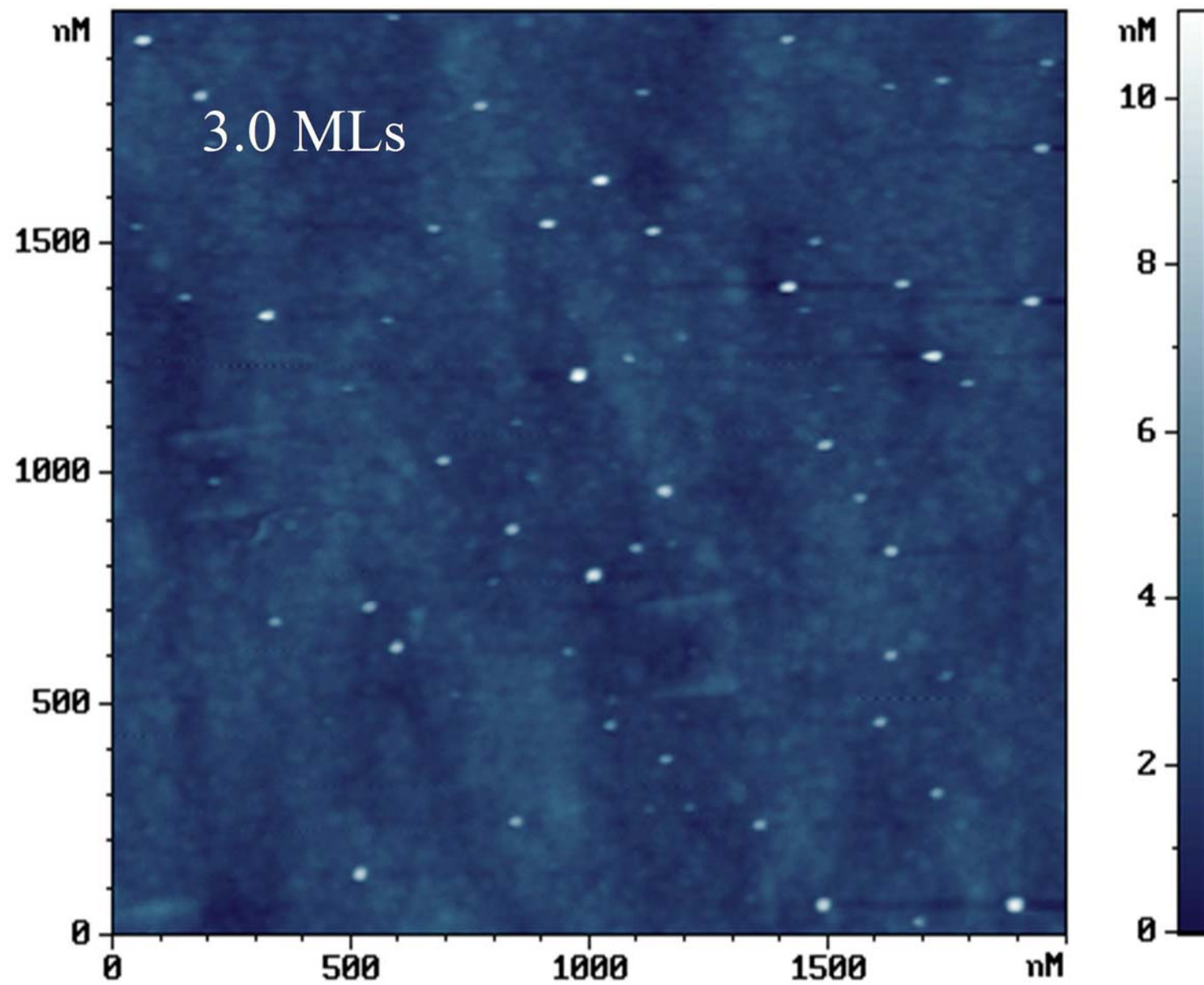


Rev Date: 11/96

超高真空操作程序與重要性、分子束源種類及調控磊晶速率

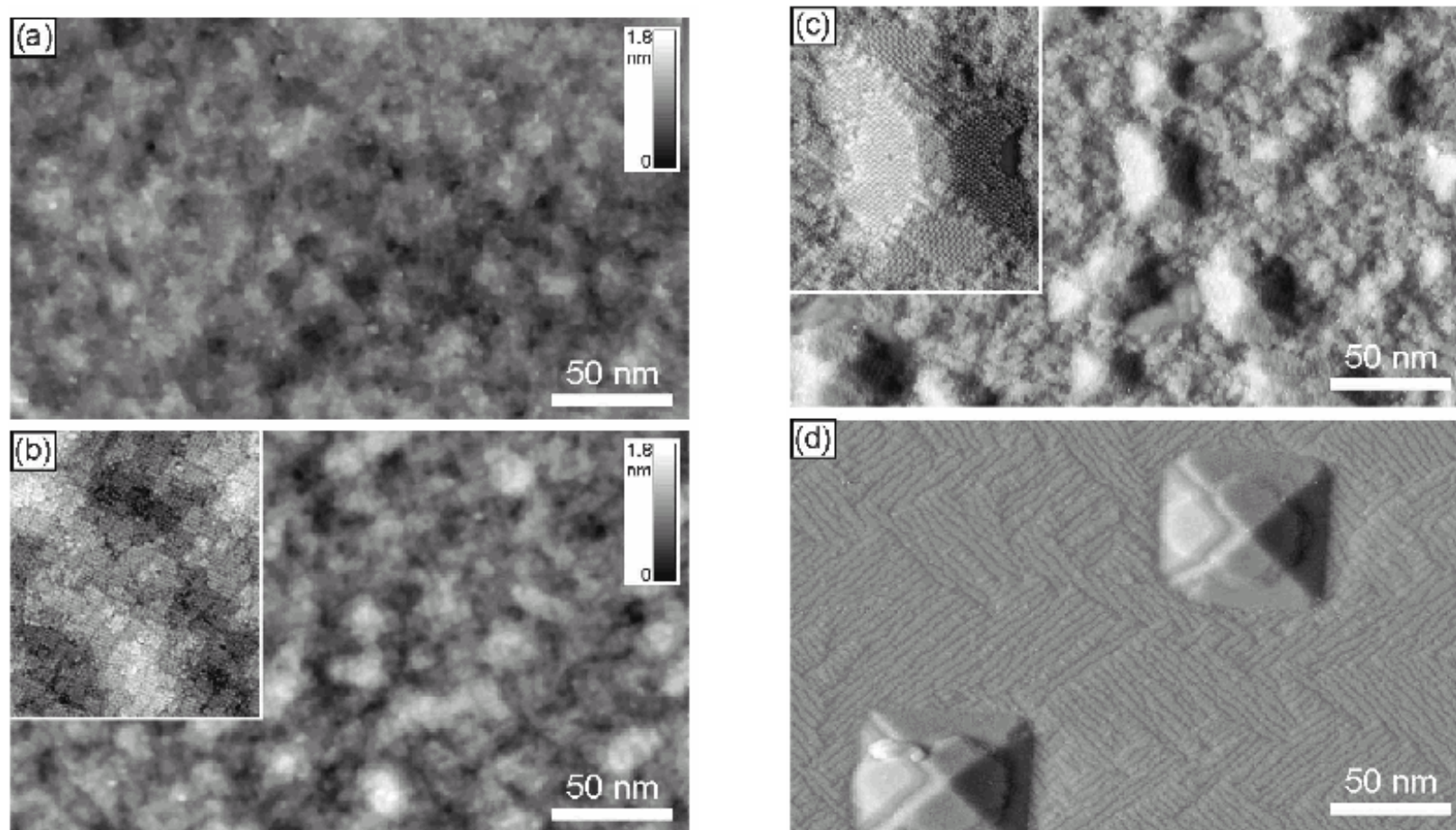
分子束磊晶術





碲化鋅量子點之表面高低(明暗)形貌直徑約10-30奈米 AFM

半導體奈米結構之形狀



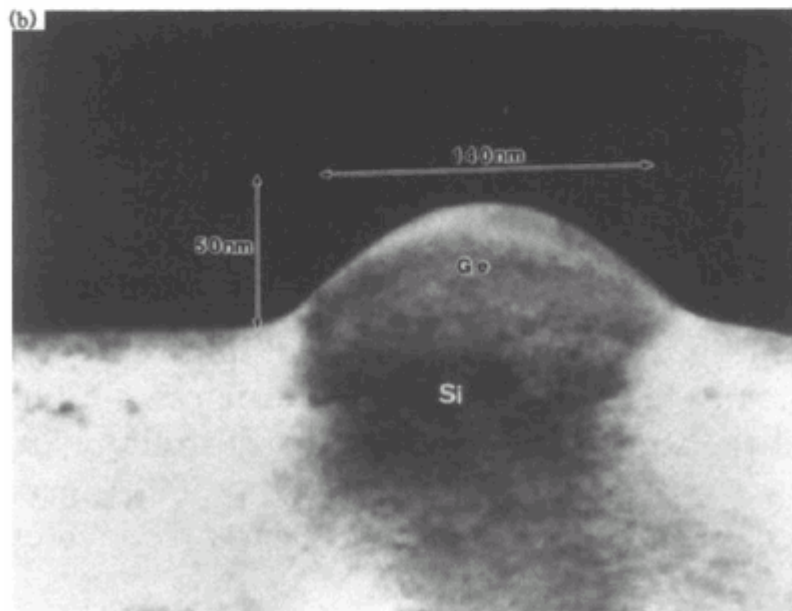
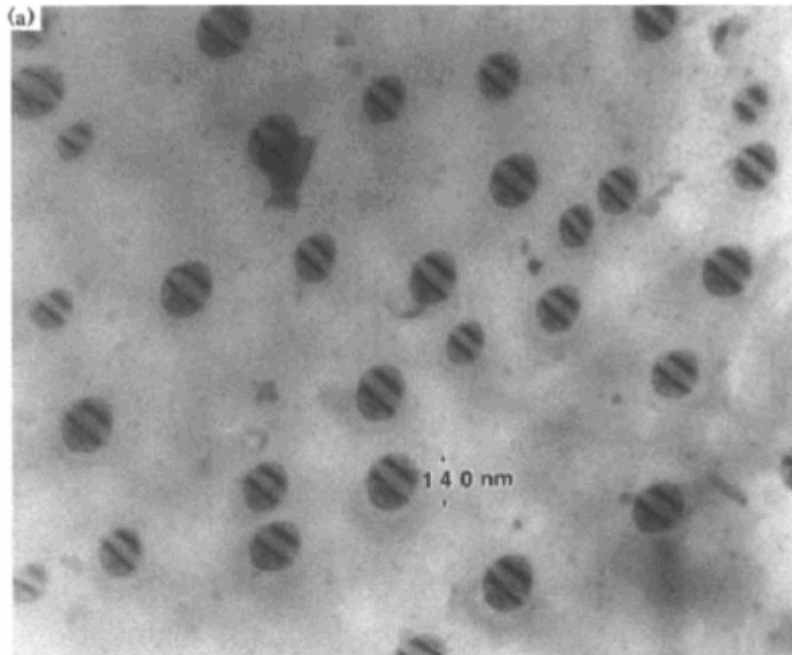
***In situ* scanning tunneling microscopy study of C-induced Ge quantum dot formation on Si(100)**

O. Leifeld et al., APL74, 994 (1999)

Dislocation-Free Stranski-Krastanow Growth of Ge on Si(100)

D. J. Eaglesham and M. Cerullo

PRL64, 1943 (1990)

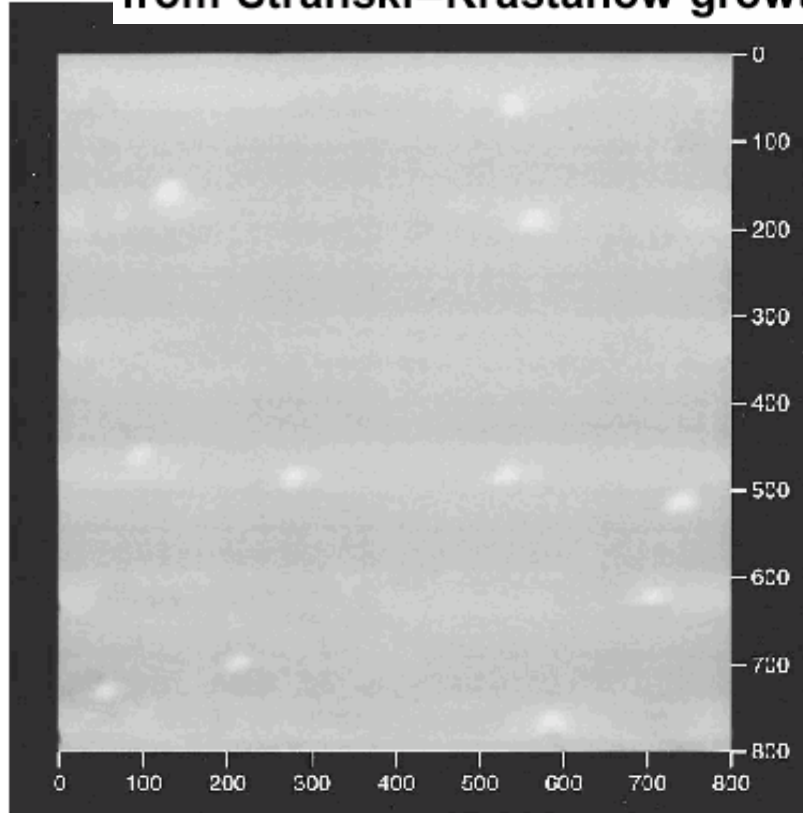


dome-shaped

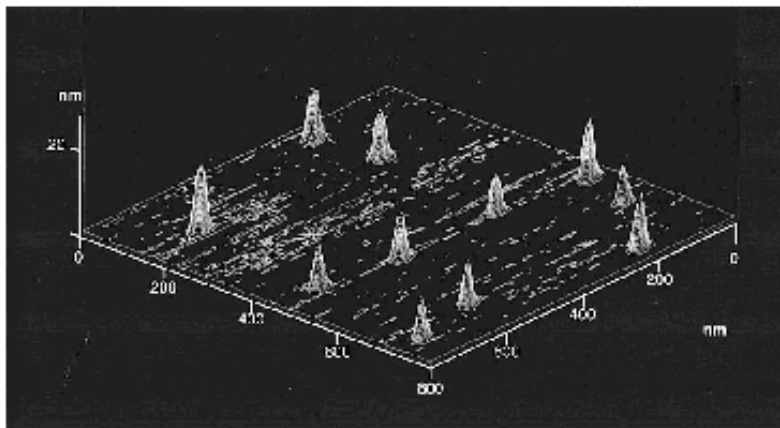
半導體奈米結構之形狀

Self-organized CdSe quantum dots onto cleaved GaAs (110) originating from Stranski–Krastanow growth mode

H.C. Ko et al., APL70, 3278 (1997)



(a)



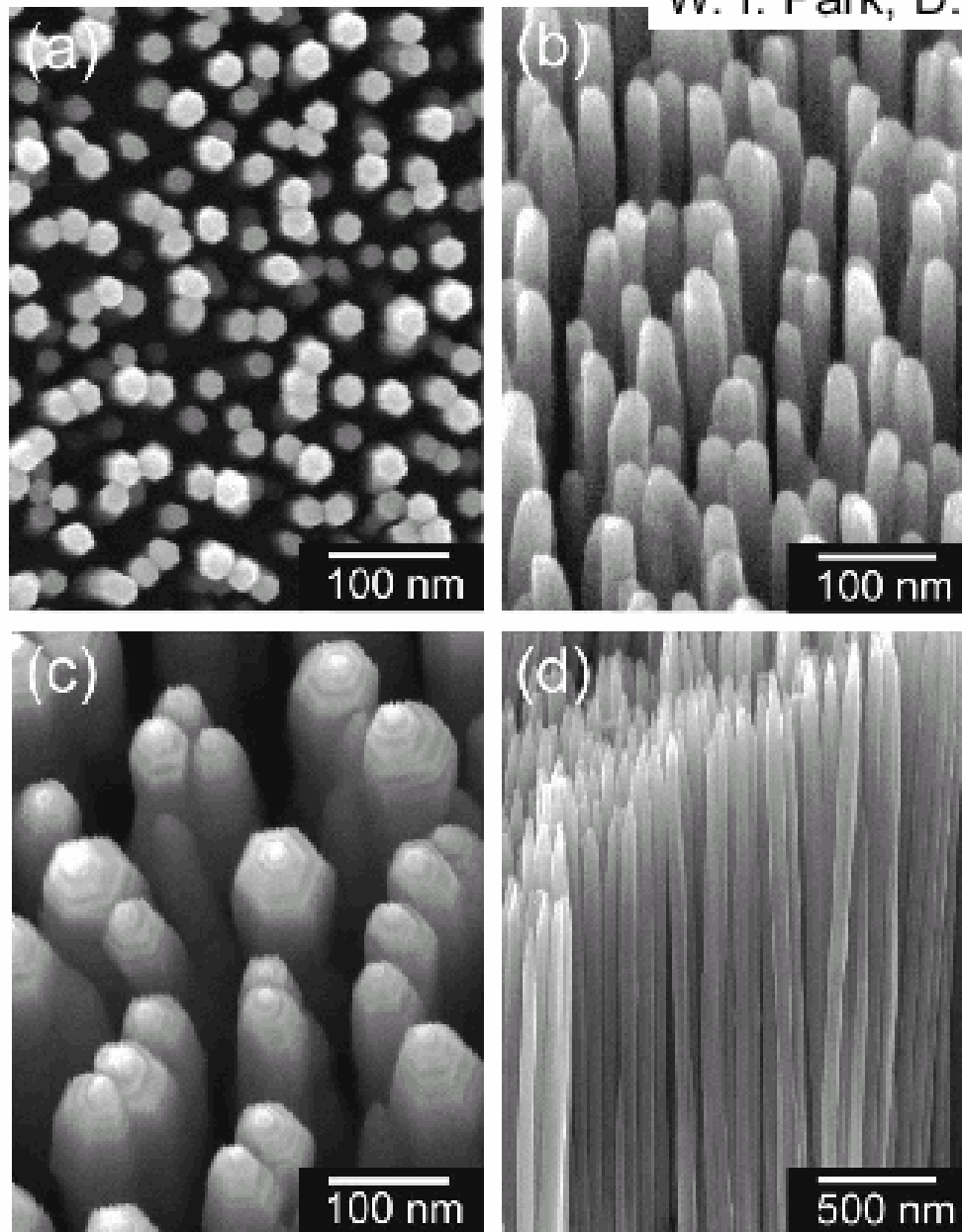
(b)

半導體奈米結構之形狀

Metalorganic vapor-phase epitaxial growth of vertically well-aligned ZnO nanorods

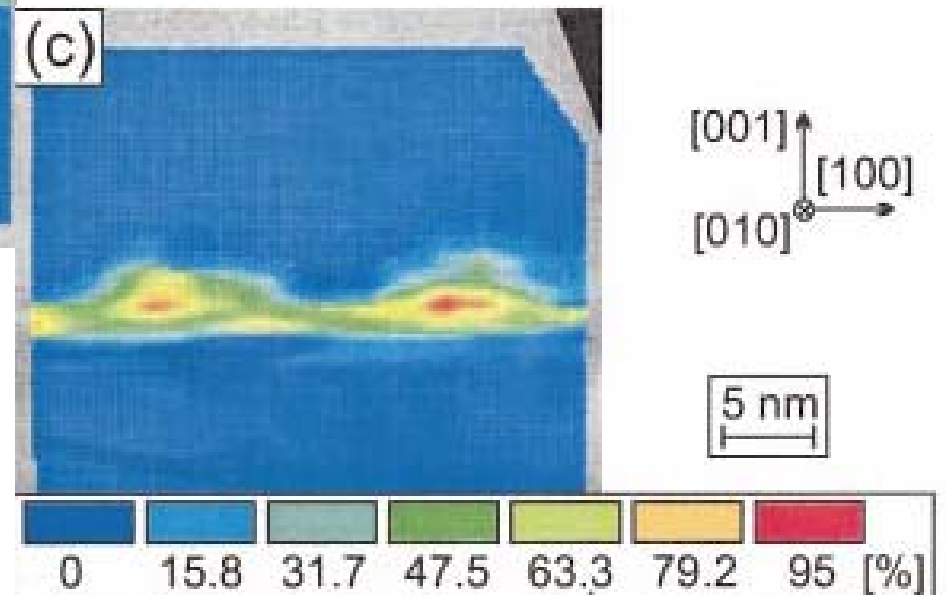
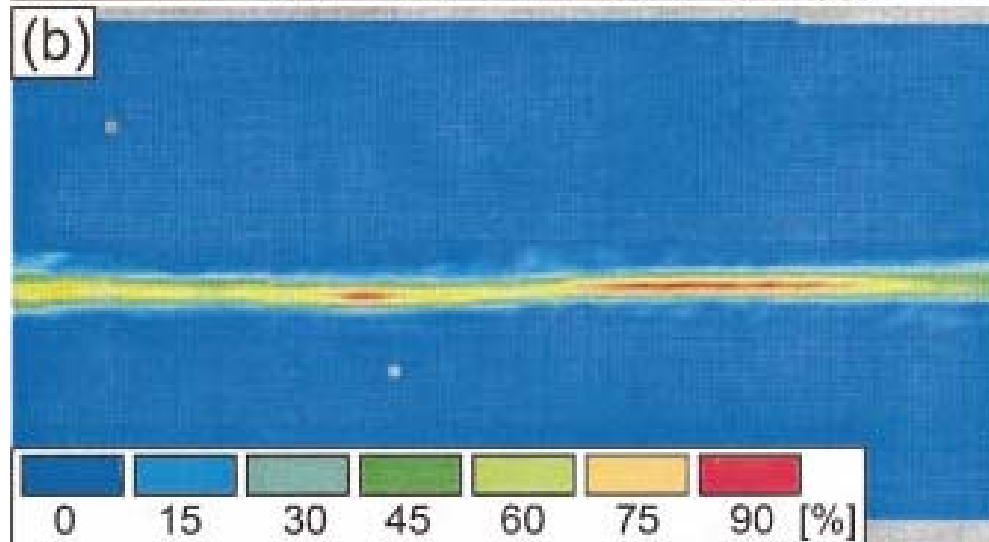
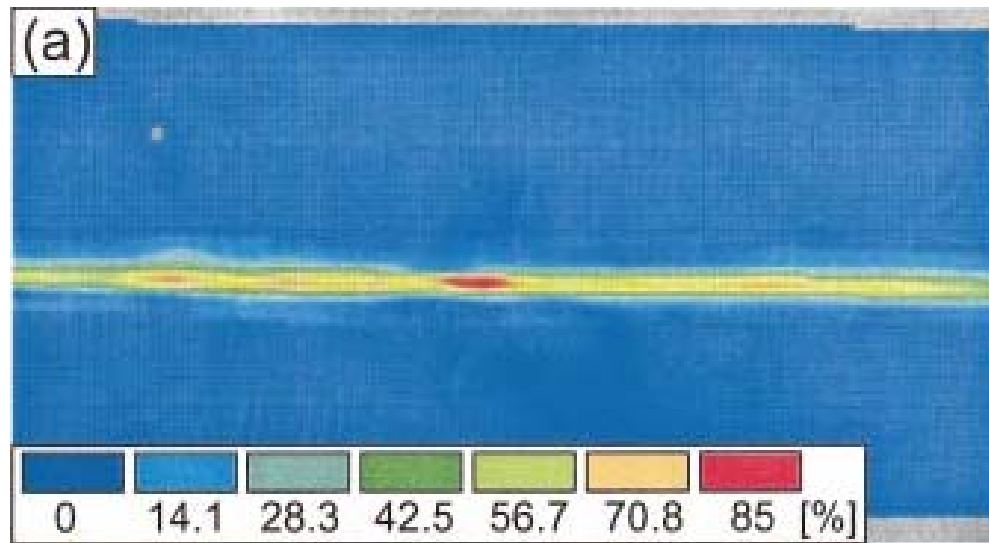
W. I. Park, D. H. Kim, S.-W. Jung, and Gyu-Chul Yi^{a)}

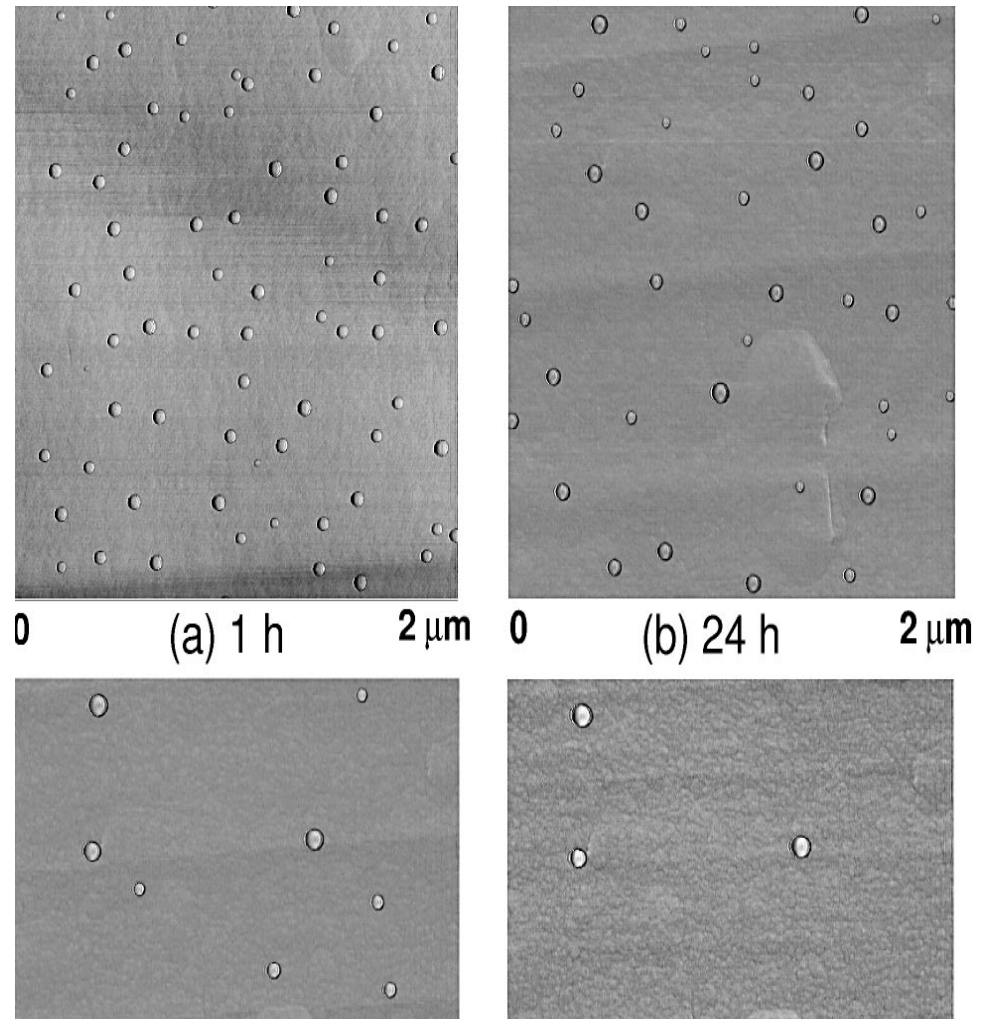
APL80, 4232 (2002)



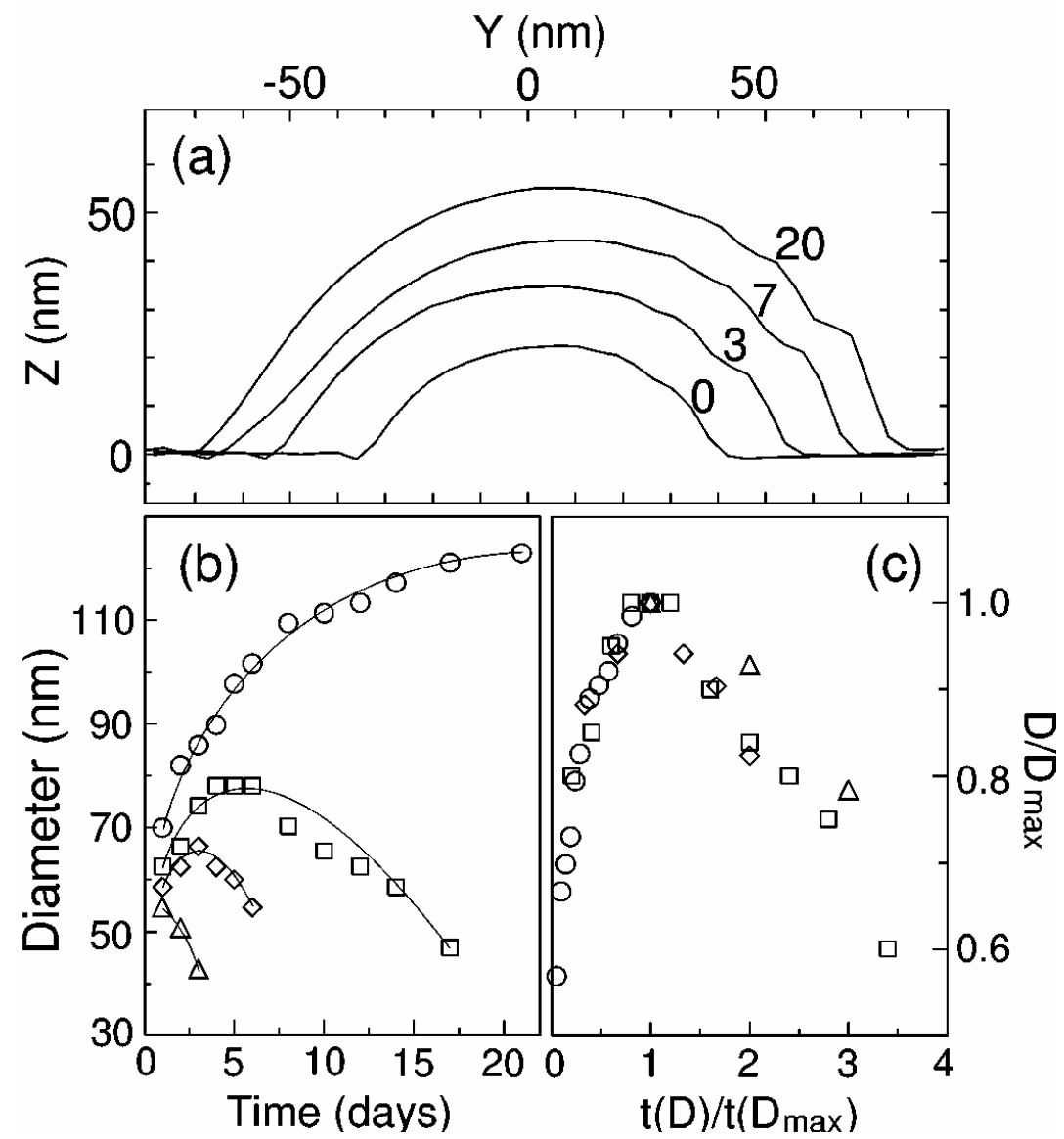
半導體奈米結構之形狀

Ref. D. Litvinov et al.
APL 81, 640 (2002)

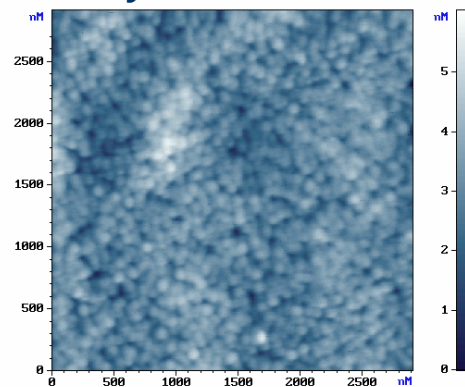




Ref. S.Lee et al., Phys. Rev. Lett. 81, 3479 (1998)

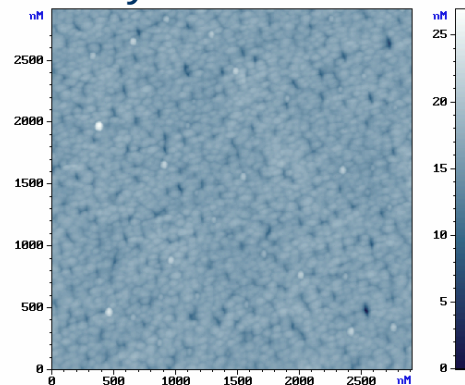


Day1

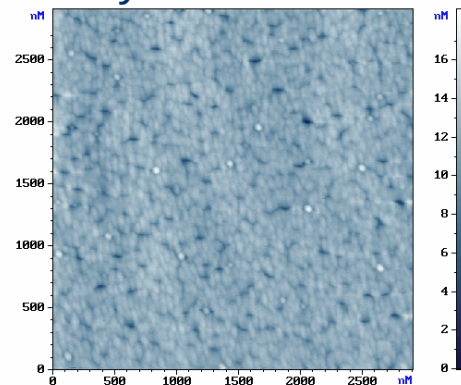


CdSe QDs 3 ML

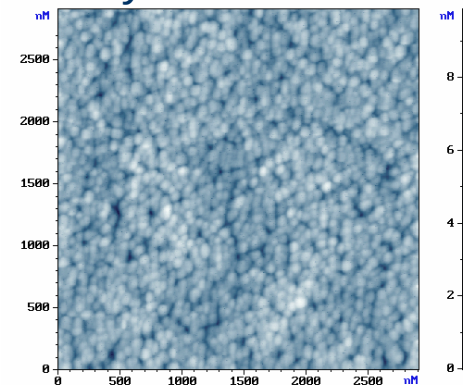
Day2 RT air



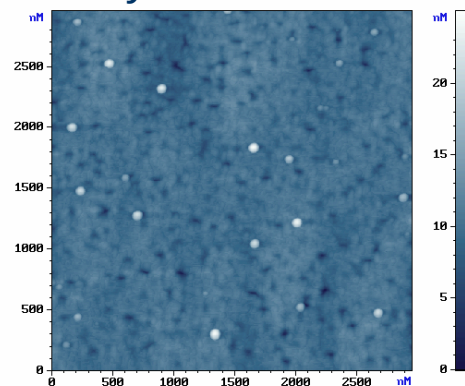
Day2 RT N2



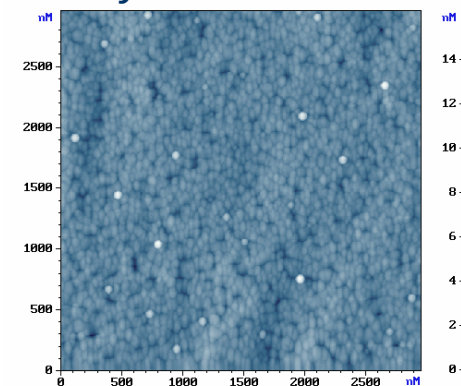
Day2 LT N2



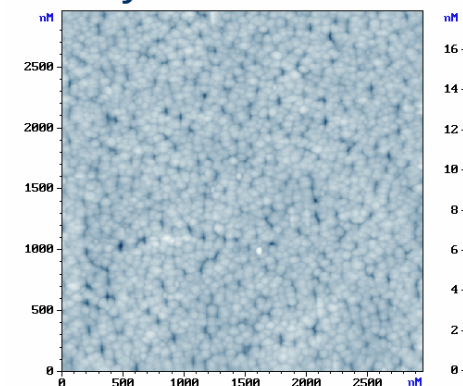
Day3 RT air



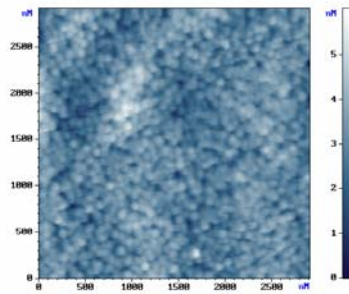
Day3 RT N2



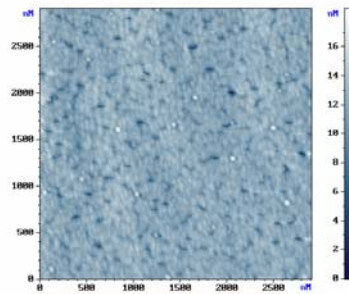
Day3 LT N2



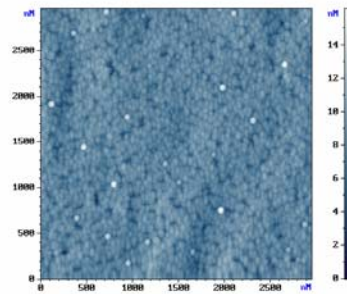
Day 1



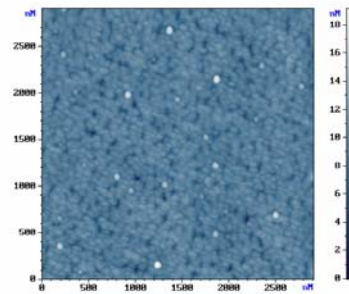
Day 2



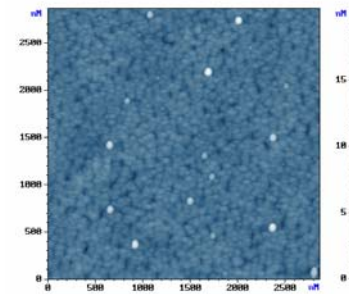
Day 3



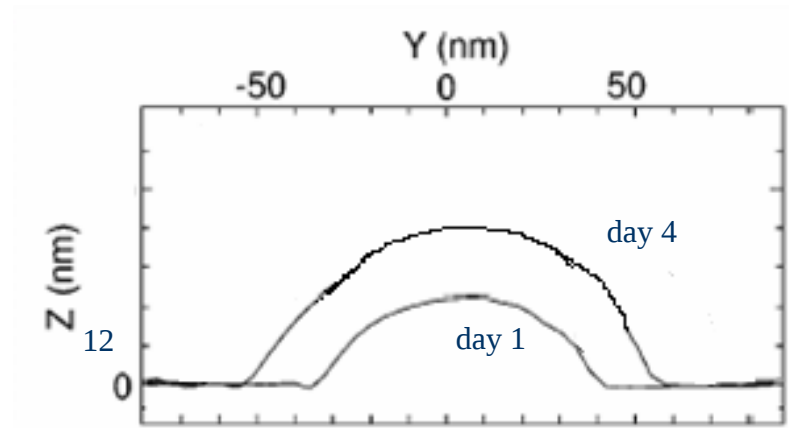
Day 4



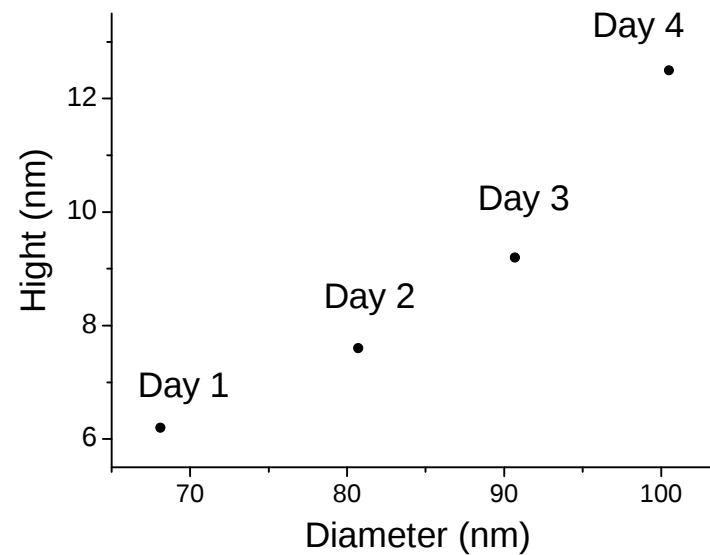
Day 5

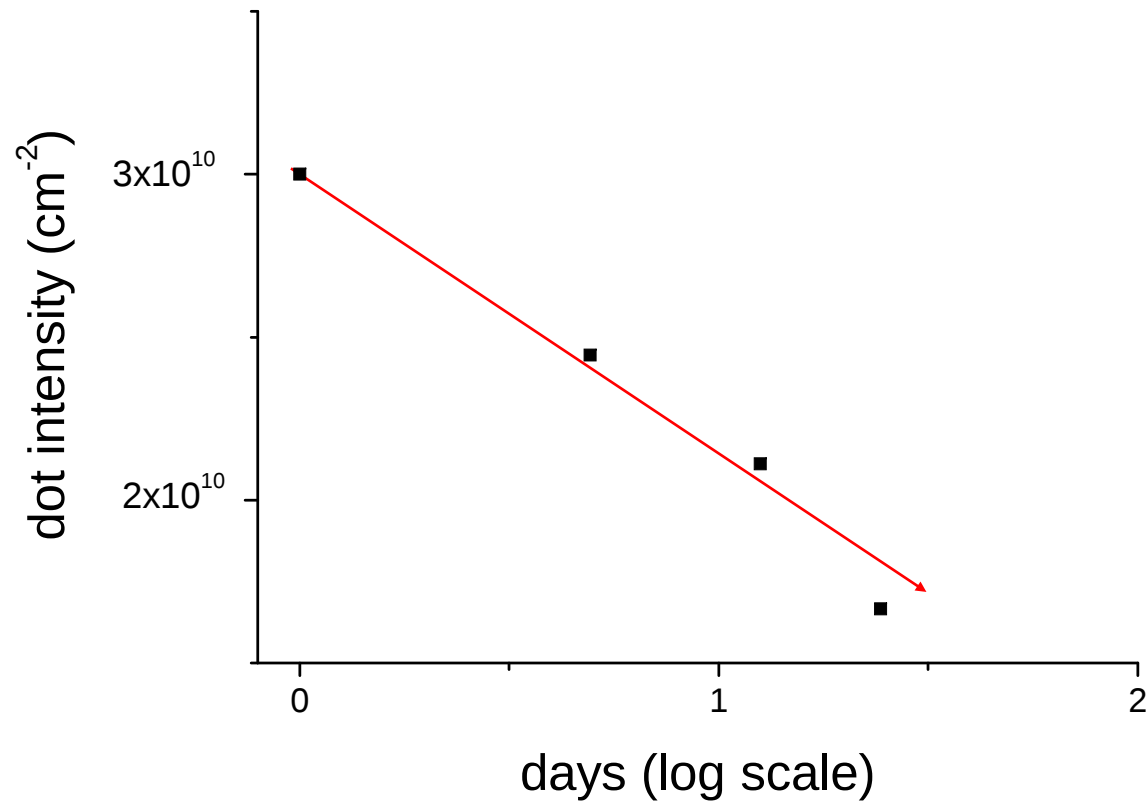


Dot size vs. Time



T (days)	D (nm)	H (nm)
4	100.5	12.5
3	90.7	9.2
2	80.7	7.6
1	68.1	6.2





$$V_{av}(t) \rho(t) = \text{const.} \quad \rho(t) = \text{const.} R_{av}(t)^{-3}$$

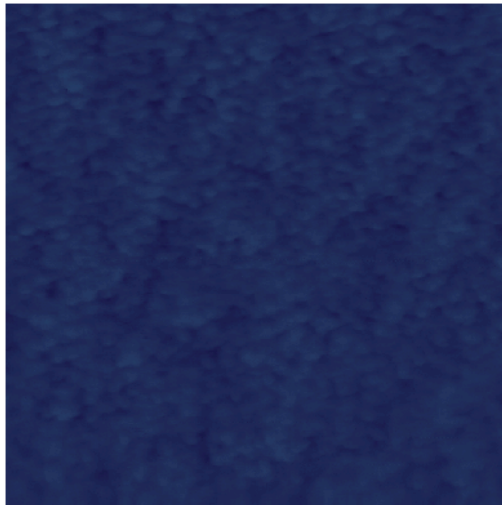
Mass transfer involves kinetic surface barrier for the atom detach from the edge of island $R_{av}(t) \sim t^{1/3}$

$$\text{Therefore, } \rho(t) \sim t^{-1}$$

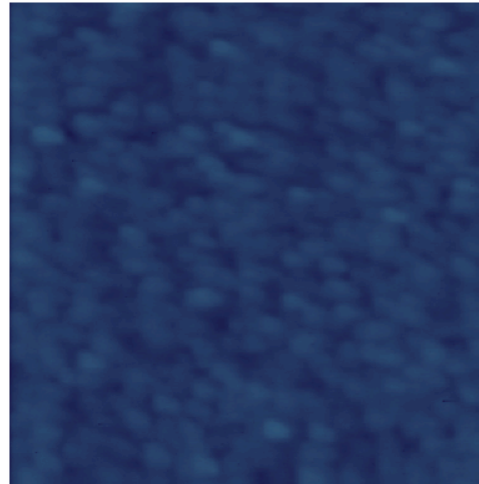
AFM non-contact mode

Find the WL thickness, 2D to 3D growth transition.

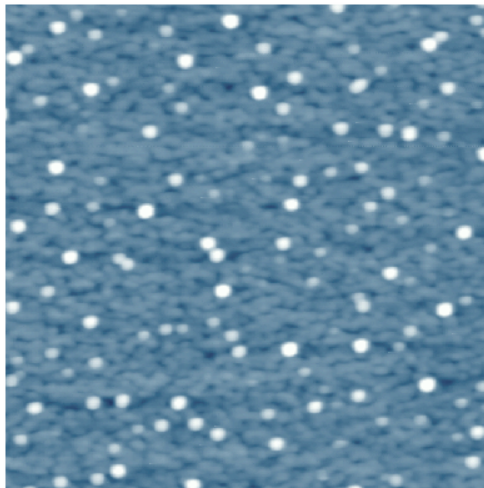
ZnSe



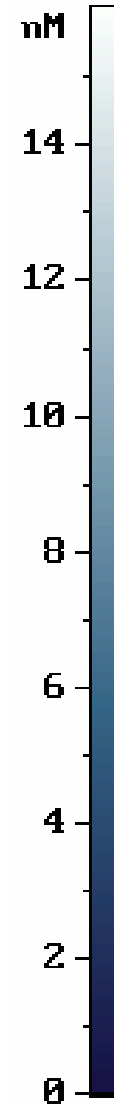
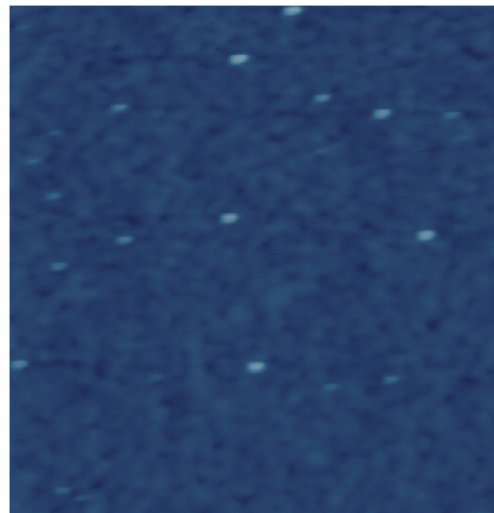
CdSe 2.5 MLs

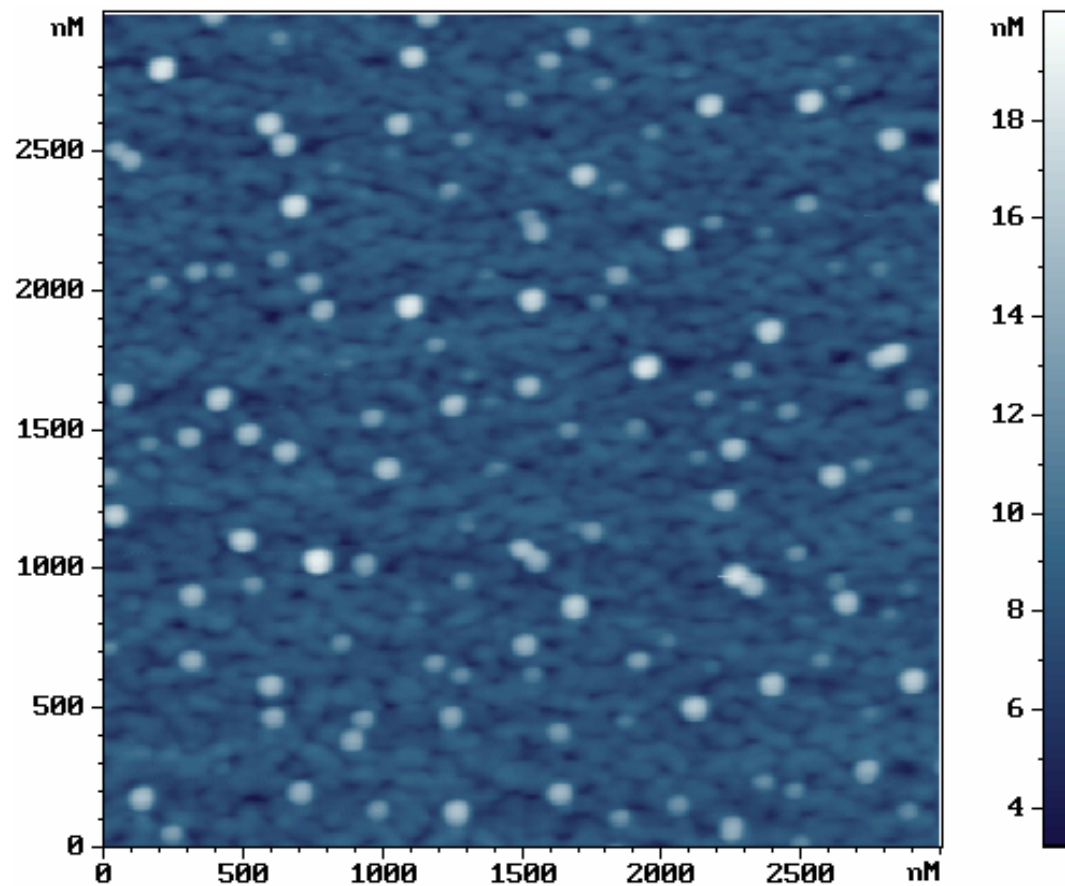


CdSe 3.0 MLs

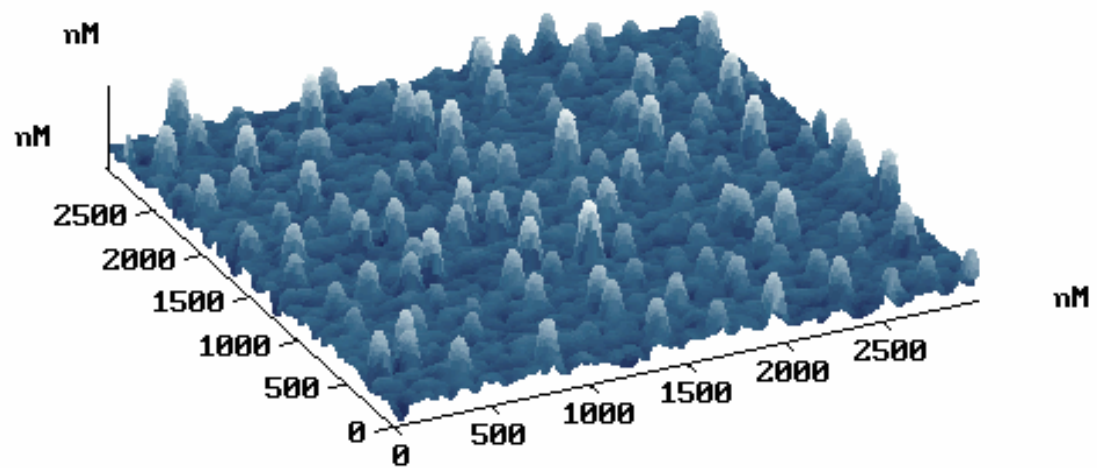


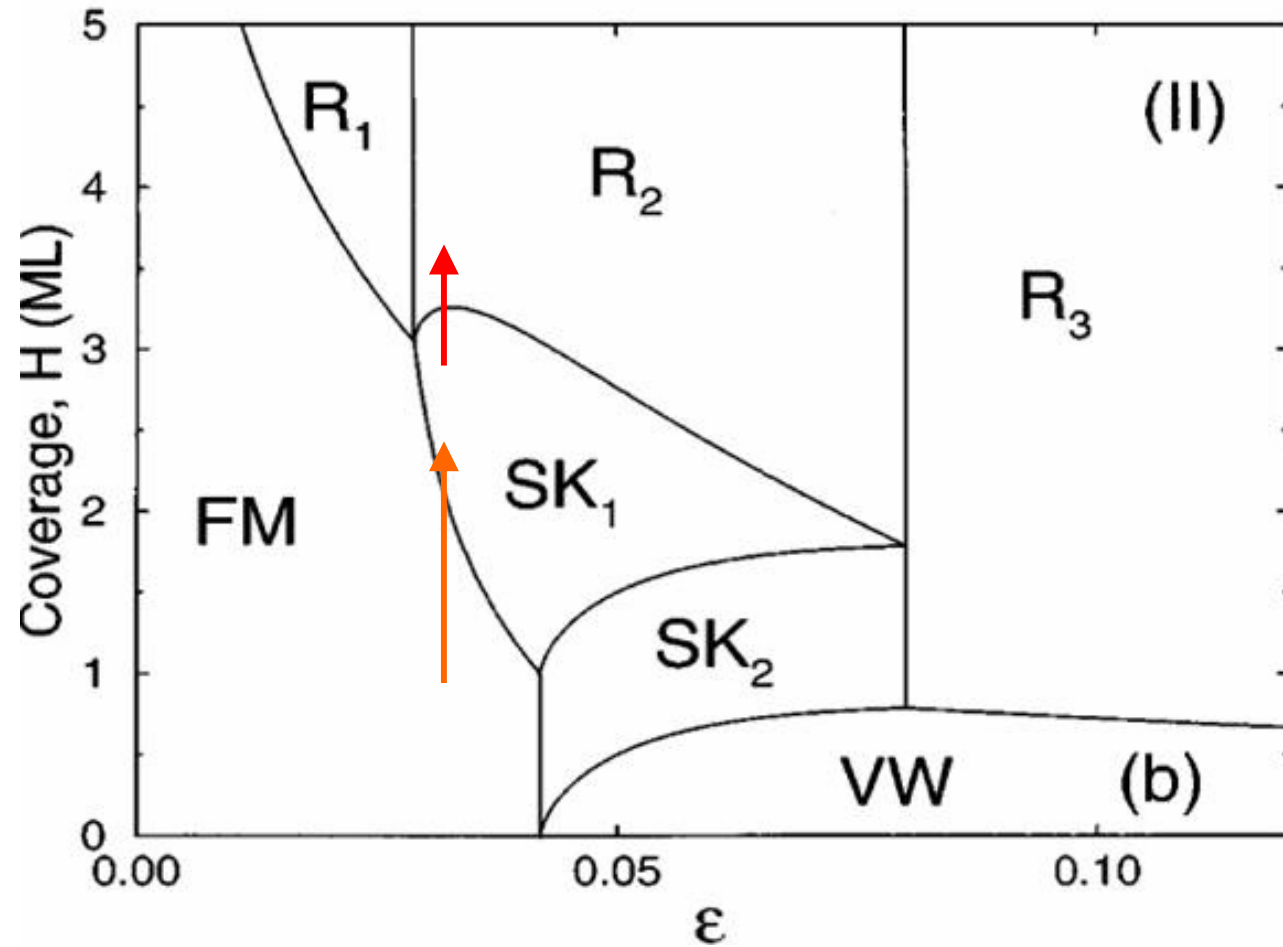
CdSe 2.7 MLs





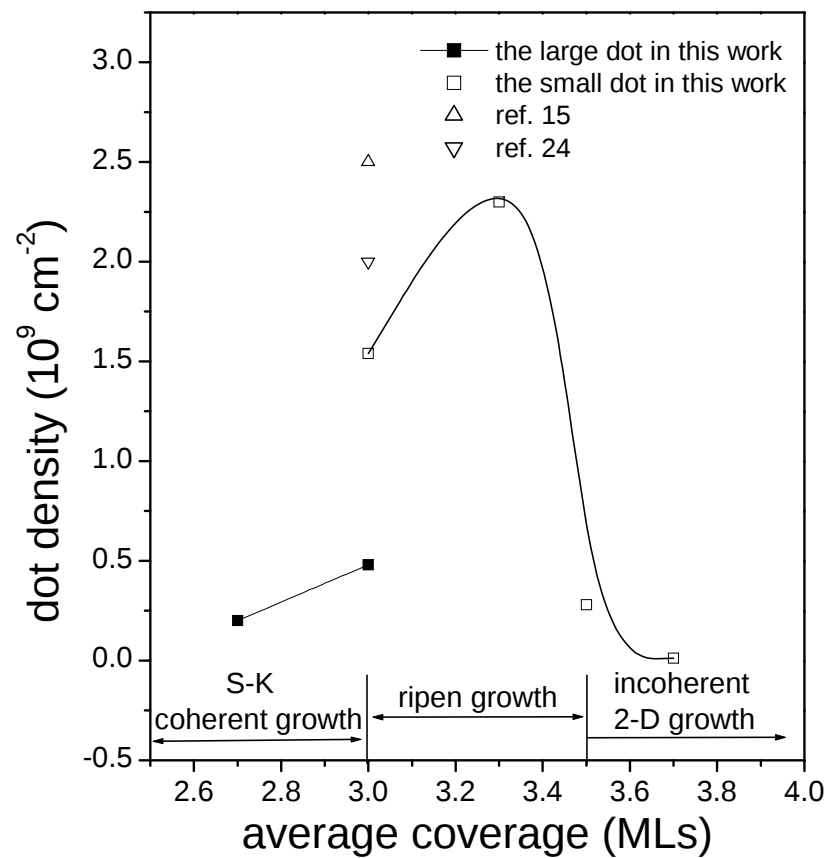
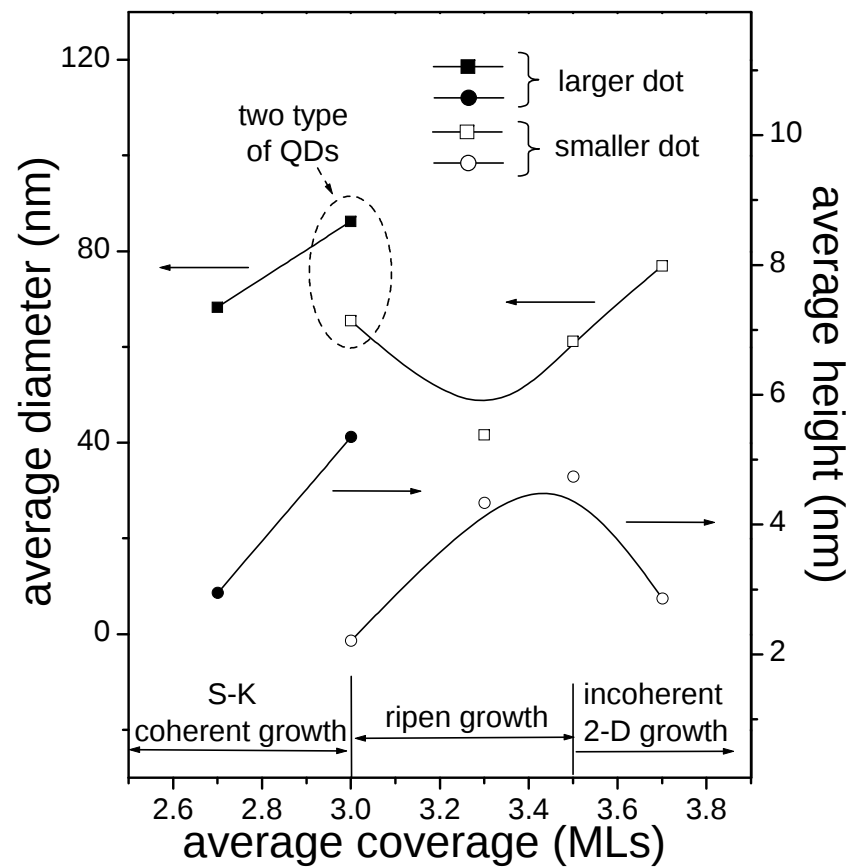
CdSe (3.0 MLs)/ZnSe



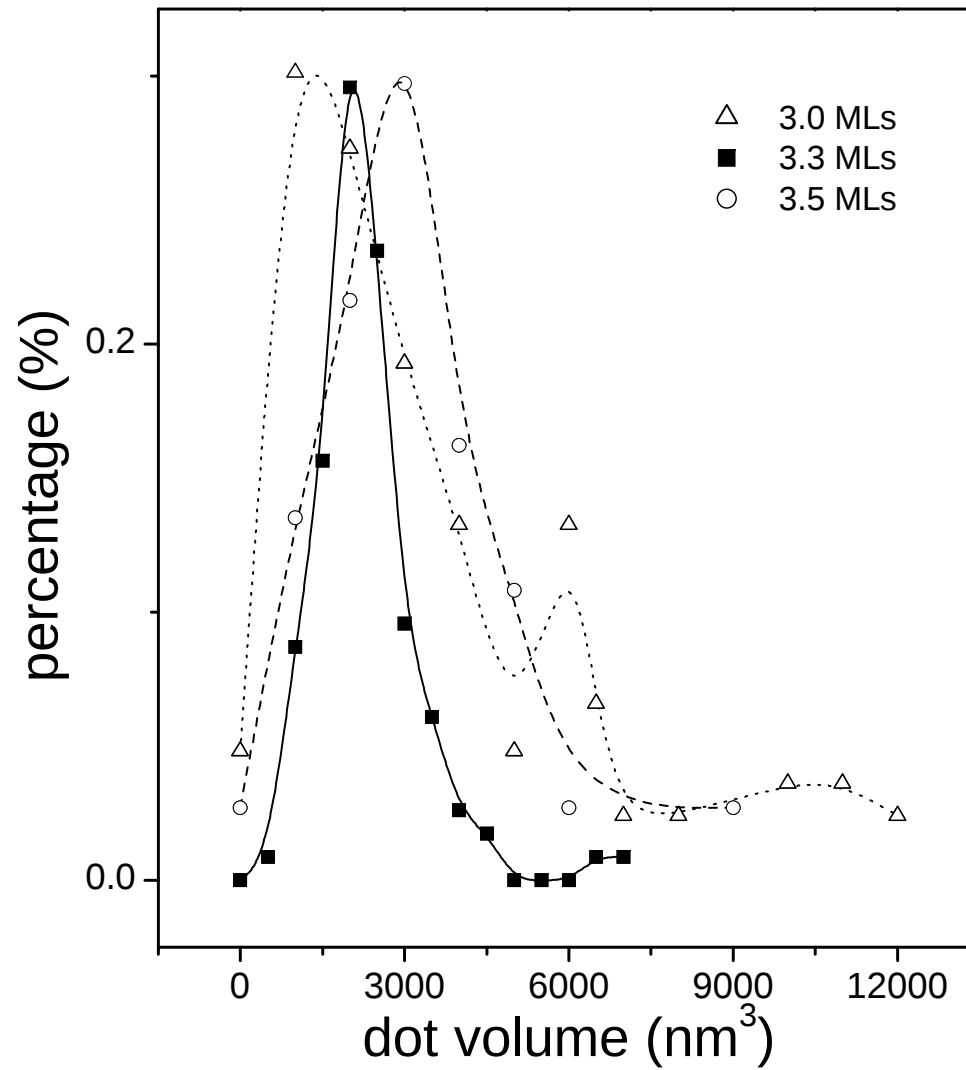


$$u(H, n_1, n_2, \varepsilon) = E_{\text{ml}}(n_1) + n_2 E_{\text{isl}} + (H - n_1 - n_2)E_{\text{rip}}$$

- ◆ I. Daruka and A.L. Barabasi, APL 72, 2102 (1998)

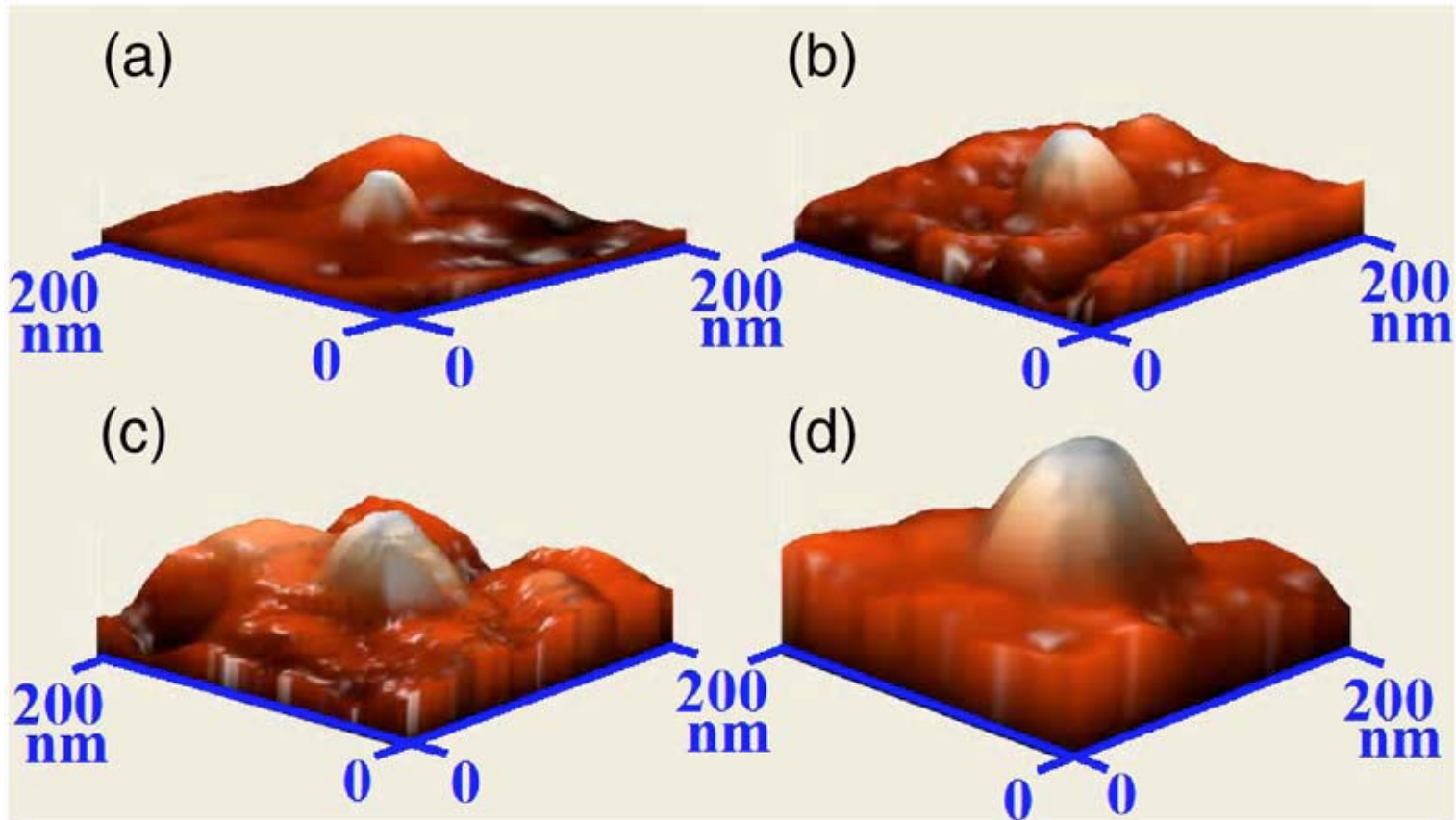


The importance of size control

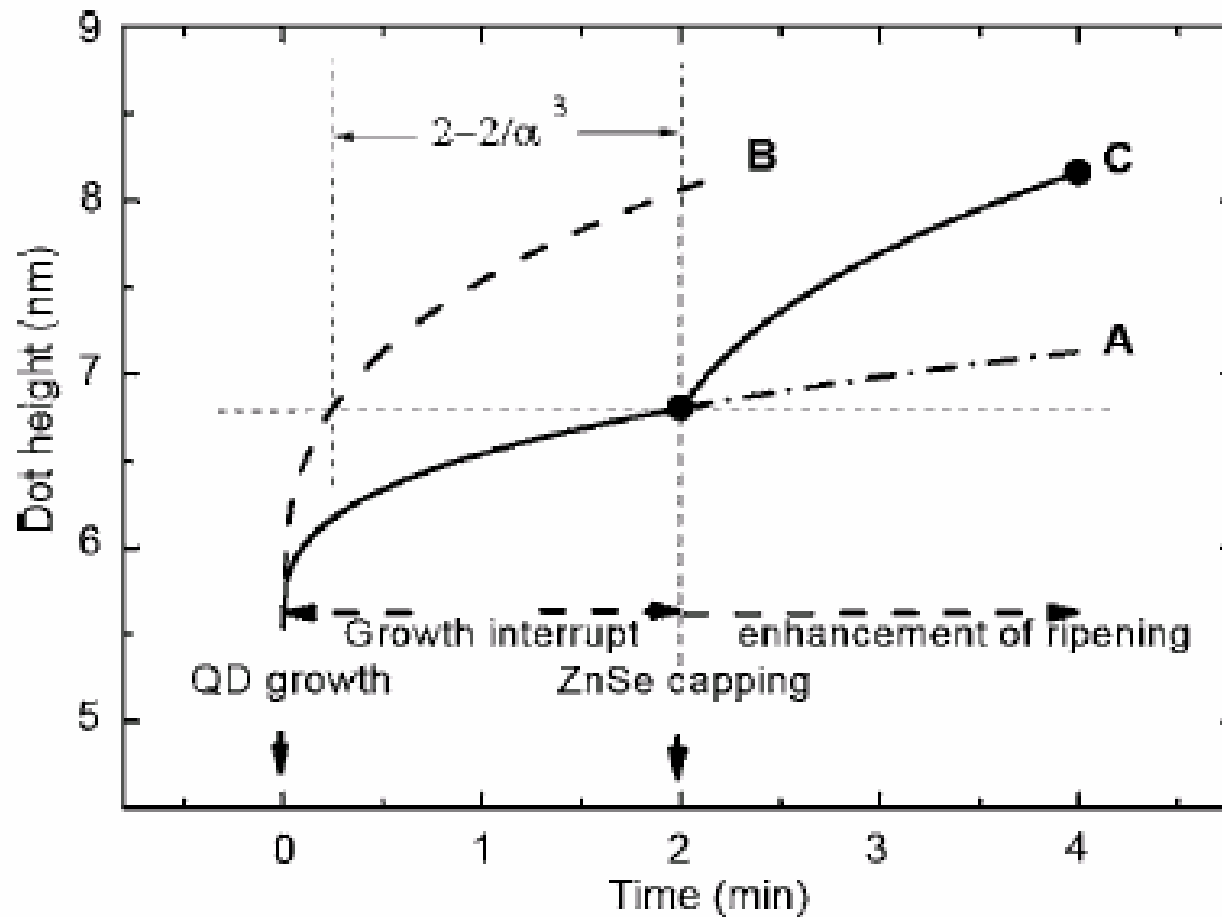


Two types of QDs.

Effect of ZnSe partial capping on the ripening dynamics of CdSe quantum dots



Typical AFM images of CdSe QDs samples capped with ZnSe layers of (a) 0, (b) 1, (c) 2, and (d) 3 ML. The temperature for ZnSe capping was 260 °C.



Dependence of dot height on time. Curve A dashed dots expresses

$$H(t) = H_0 + V_0 \times t^{1/3},$$

Curve B dashed line represents the ripening of a QD which has a faster ripening rate.

Curve C solid line describes

$$H(t) = H_0 + V \left[t - \left(2 - \frac{2}{\alpha^3} \right) \right]^{1/3},$$

Lai et al.
APL 90, 083226
(2007)

